IoT Services, Applications, Platform, and Protocols

Guest Editor:

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Message from the Guest Editor

With the explosive growth of Internet-of-Things (IoT)
services in the world, IoT-based services and applications
have been developed and deployed in the related industry,
which include smart home/appliances, smart farms, smart
factories, and smart healthcare. The platform and
protocols for IoT services/applications are also becoming
the key challenging issues in IoT-related research and
engineering for future Internet.

This Special Issue focuses on the emerging services and
applications for IoT and the R&D progresses on platforms
and protocols for IoT services and applications. The topics
of interest include but are not limited to:

- New or advanced IoT services and applications;
- Framework or architecture for IoT services and applications;
- Research and experimentation on IoT platforms;
- Performance analysis and enhancement of IoT messaging protocols (e. g., CoAP, MQTT);
- Networking protocols for IoT;
- Recent R&D activities and experimentations on IoT;
- International Standardizations on IoT (IETF, IEEE, 3GPP, OneM2M, OCF, etc.).

Welcome to contribute!

Special Issue

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Message from the Editor-in-Chief

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